

# **Dual N-Channel 100 V (D-S) Super Junction MOSFET**

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	R <sub>DS(on)</sub> (mΩ)(Typ.)	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
100	30 at V <sub>GS</sub> = 10 V	15	6.9 nC			
100	40 at V <sub>GS</sub> = 4.5 V	15				

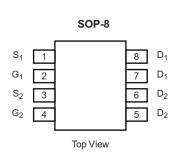
### **FEATURES**

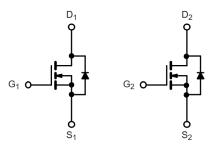
- DT-SJ Power MOSFET
- 100 % R<sub>g</sub> and UIS tested
- Extremely Low Qg for Switching Losses
- Compliant to RoHS Directive 2002/95/EC



#### **APPLICATIONS**

· Primary Side Switch





N-Channel MOSFET

N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T <sub>A</sub> = 25 °C, unless otherwise noted)					
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	100	V	
Gate-Source Voltage		$V_{GS}$	± 20		
	T <sub>C</sub> = 25 °C		15		
Continuous Drain Current (T <sub>.I</sub> = 150 °C)	T <sub>C</sub> = 70 °C	1 ,	13		
Continuous Diain Current (1) = 130 C)	T <sub>A</sub> = 25 °C	- I <sub>D</sub>	6.2 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C	1	5.3 <sup>b, c</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	60	7	
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C		15		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	Is	3.3 <sup>b, c</sup>		
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	13.5		
Single Pulse Avalanche Energy		E <sub>AS</sub>	14.8	mJ	
	T <sub>C</sub> = 25 °C		14		
Maximum Power Dissipation	$T_C = 70 ^{\circ}C$	P <sub>D</sub>	8.96	$\square$ w	
Waximum Tower Dissipation	T <sub>A</sub> = 25 °C	] '	3.2 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C	1	2.05 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	40	60	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	20	40	] 0/11	

#### Notes:

- a. Based on  $T_C = 25 \,^{\circ}\text{C}$ .
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s
- d. Maximum under steady state conditions is 80 °C/W.





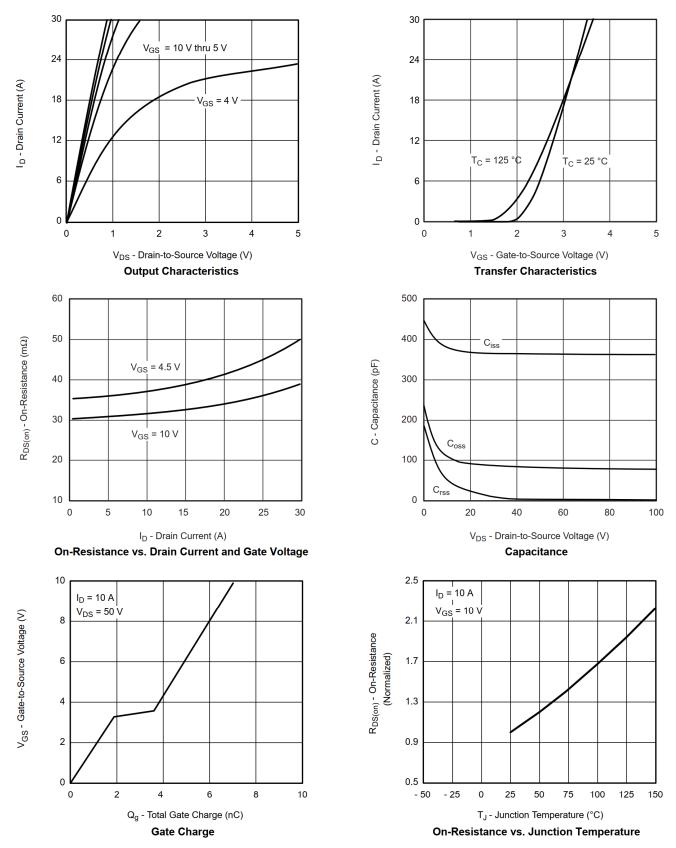
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	· · · · · · · · · · · · · · · · · · ·						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$	100			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I = 250 ·· A		172		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA		- 10			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_{D} = 250 \mu A$	1		3	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Cata Valta na Duain Comunit		V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V			1		
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10	μA	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	15			Α	
Dunin Course On Otata Danistanana	, ,	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A		30	40		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A}$		35	50	mΩ	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 10 A		25		S	
Dynamic <sup>b</sup>	, ,						
Input Capacitance	C <sub>iss</sub>			368		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 50 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		80			
Reverse Transfer Capacitance	C <sub>rss</sub>			3			
Total Gate Charge	Qg			6.9		nC	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 50 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$		3.8			
Gate-Drain Charge	Q <sub>gd</sub>			1.5			
Gate Resistance	R <sub>g</sub>	f = 1 MHz		2.5		Ω	
Turn-on Delay Time	t <sub>d(on)</sub>			6			
Rise Time	t <sub>r</sub>	$V_{DD} = 50 \text{ V}, R_{L} = 10 \Omega$		18			
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 10 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		12			
Fall Time	t <sub>f</sub>			9		] no	
Turn-On Delay Time	t <sub>d(on)</sub>			13		ns	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 50 V, $R_L$ = 10 $\Omega$		10		_	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 8 \text{ A}, V_{GEN} = 8 \text{ V}, R_g = 1 \Omega$		20			
Fall Time	t <sub>f</sub>			6		1	
<b>Drain-Source Body Diode Characteristic</b>	s						
Continuous Source-Drain Diode Current	Is	T <sub>C</sub> = 25 °C			15		
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				60	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 1 A		0.7	1	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			30		ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	0		40		nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = 10 \text{ A, dI/dt} = 100 \text{ A/µs, T}_J = 25 ^{\circ}\text{C}$		20		ns	
Reverse Recovery Rise Time	t <sub>b</sub>	•		18			

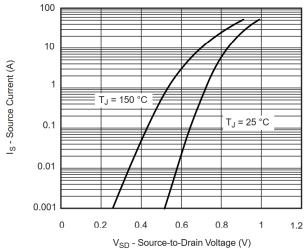
#### Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

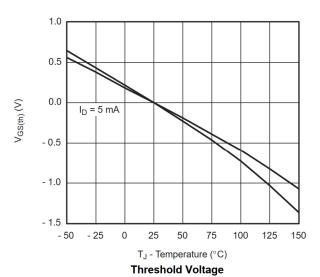
a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 % a. Guaranteed by design, not subject to production testing.



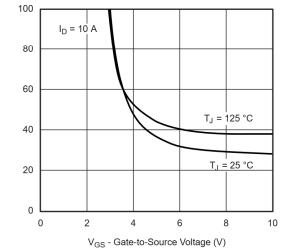




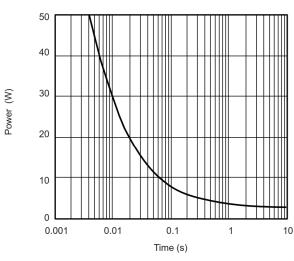
Source-Drain Diode Forward Voltage



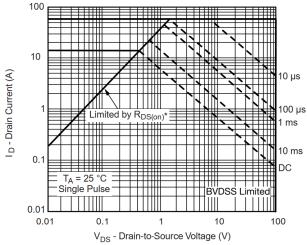
 $R_{DS(on)}$  - On-Resistance (m $\Omega$ )



On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

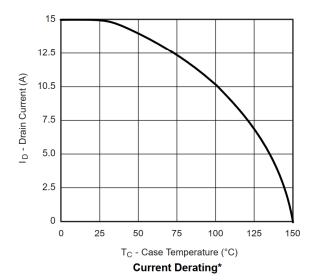


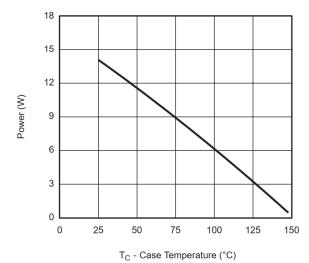
\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area, Junction-to-Ambient



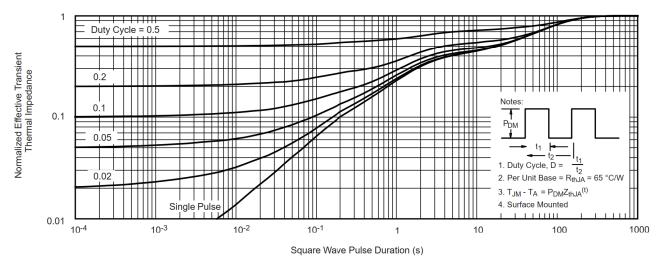




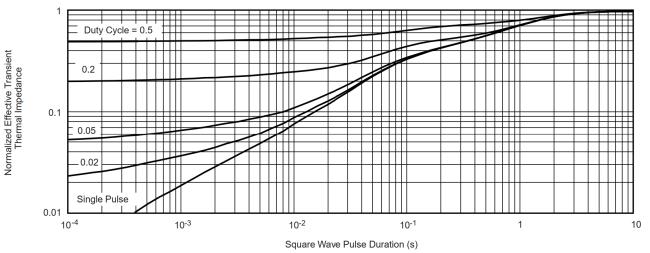


Power Derating, Junction-to-Foot





Normalized Thermal Transient Impedance, Junction-to-Ambient

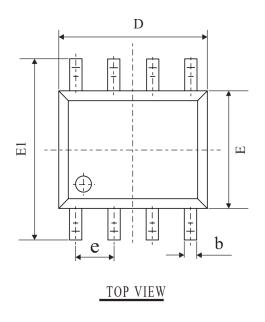


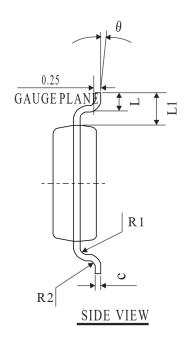
Normalized Thermal Transient Impedance, Junction-to-Foot

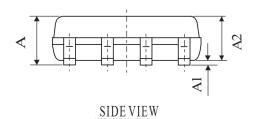




# **SOP-8 PACKAGE OUTLINE**







COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	TYP	MAX	
A	1.30	1.60	1.85	
A1	0.03	0.15	0.28	
A2	1.20	1.45	1.70	
b	0.26	0.40	0.54	
С	0.132	0.203	0.273	
D	4.50	4.90	5.30	
Е	3.50	3.00	4.30	
E1	5.50	6.00	6.50	
L	0.30	0.70	1.10	
θ	2°	4°	6°	
L1	1.04REF			
e	1.27BSC			
R1	0.07TYP			
R2	0.07TYP			





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